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APPLICANTS

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\*\* CONTINUING DATA \*\*\*\*\*

This application is a CON of 10/165,344 06/07/2002 PAT 6,686,996  
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\*\* FOREIGN APPLICATIONS \*\*\*\*\*

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35 USC 119 (a-d) conditions met <input checked="" type="checkbox"/> yes <input type="checkbox"/> no <input type="checkbox"/> Met after Allowance	Verified and Acknowledged	Examiner's Signature <i>[Signature]</i>	Initials	

ADDRESS

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TITLE

Method and apparatus for scanning, stitching, and damping measurements of a double-sided metrology inspection tool

☐ All Fees